


Search Notes 	Application/Control No. 10523642	Applicant(s)/Patent Under Reexamination BALLAND-LONGEAU ET AL.
	Examiner Heincer, Liam J	Art Unit 4134

SEARCHED			
Class	Subclass	Date	Examiner
528	86	10/11/07	LH
528	220, 391	9/2/2010	LH
521	27	9/2/2010	LH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	10/12/07	LH
Inventor Name Search	10/11/07	LH
STIC STN Structure Search	10/10/07	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	10/31/08	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	6/8/2009	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	3/8/2010	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	9/2/2010	LH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
528	220, 391	9/2/2010	LH
521	27		

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